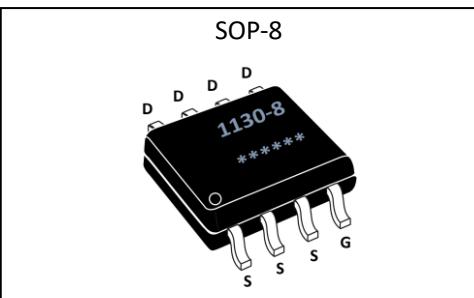


**GL Silicon N-Channel Power MOSFET**
**General Description:**

The GL1130-8 uses advanced trench technology and design to provide excellent RDS(ON) with low gate charge. It can be used in a wide variety of applications. The package form is SOP-8, which accords with the RoHS standard.

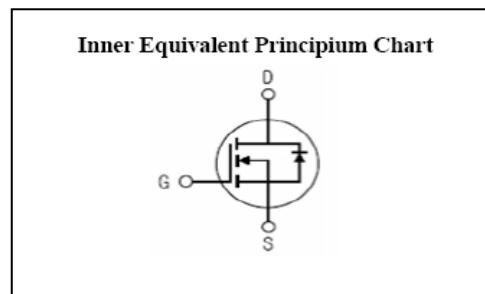
$V_{DSS}$	30	V
$I_D$	8	A
$P_D$	2.5	W
$R_{DS(ON)MAX}$	20	$m\Omega$


**Features:**

- Fast Switching
- Low Gate Charge and Rdson
- Low Reverse transfer capacitances
- 100% Single Pulse avalanche energy Test

**Applications:**

- PWM applications
- Load switch
- Power management


**Absolute (Tc=25°C unless otherwise specified):**

Symbol	Parameter	Rating	Units
$V_{DSS}$	Drain-to-Source Voltage	30	V
$I_D$	Continuous Drain Current	8	A
	Continuous Drain Current $T_C = 70^\circ C$	6	A
$I_{DM}^{a1}$	Pulsed Drain Current	32	A
$V_{GS}$	Gate-to-Source Voltage	$\pm 20$	V
$E_{as}^{a2}$	$L=0.1mH$	28	$mJ$
$dv/dt^{a3}$	Peak Diode Recovery $dv/dt$	5.0	$V/ns$
$P_D$	Power Dissipation	2.5	W
$T_J, T_{stg}$	Operating Junction and Storage Temperature Range	150, -55 to 150	$^\circ C$
$T_L$	Maximum Temperature for Soldering	300	$^\circ C$



## GL Silicon N-Channel Power MOSFET

**Electrical Characteristics** ( $T_c=25^\circ C$  unless otherwise specified):

OFF Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$V_{DSS}$	Drain to Source Breakdown Voltage	$V_{GS}=0V, I_D=-250\mu A$	30	--	--	V
$\Delta BV_{DSS}/\Delta T_J$	Bvdss Temperature Coefficient	$I_D=-250\mu A$ , Reference $25^\circ C$	--	0.1	--	$V/^\circ C$
$I_{DSS}$	Drain to Source Leakage Current	$V_{DS}=30, V_{GS}=0V, T_a=25^\circ C$	--	--	1	$\mu A$
		$V_{DS}=24V, V_{GS}=0V, T_a=125^\circ C$	--	--	250	
$I_{GSS(F)}$	Gate to Source Forward Leakage	$V_{GS} = +20V$	--	--	1	$\mu A$
$I_{GSS(R)}$	Gate to Source Reverse Leakage	$V_{GS} = -20V$	--	--	-1	$\mu A$

ON Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$R_{DS(ON)}$	Drain-to-Source On-Resistance	$V_{GS}=10V, I_D=5A$	--	11	20	$m\Omega$
$R_{DS(ON)}$	Drain-to-Source On-Resistance	$V_{GS}=4.5V, I_D=5.0A$	--	15	26	$m\Omega$
$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu A$	0.5	--	1.5	V
Pulse width $t_p \leq 380\mu s, \delta \leq 2\%$						

Dynamic Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$g_{fs}$	Forward Transconductance	$V_{DS}=5V, I_D=10A$	15	--	--	S
$C_{iss}$	Input Capacitance	$V_{GS}=0V, V_{DS}=15V$	--	680	--	pF
$C_{oss}$	Output Capacitance	$f=1.0MHz$	--	160	--	
$C_{rss}$	Reverse Transfer Capacitance		--	80	--	

Resistive Switching Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$t_{d(ON)}$	Turn-on Delay Time	$I_D=1A, V_{DD}=25V$	--	13	--	ns
$t_r$	Rise Time		--	8	--	
$t_{d(OFF)}$	Turn-Off Delay Time		--	40	--	
$t_f$	Fall Time		--	30	--	
$Q_g$	Total Gate Charge	$I_D=5A, V_{DD}=30V$	--	8	--	nC
$Q_{gs}$	Gate to Source Charge		--	4.8	--	
$Q_{gd}$	Gate to Drain ( "Miller" )Charge		--	2.2	--	

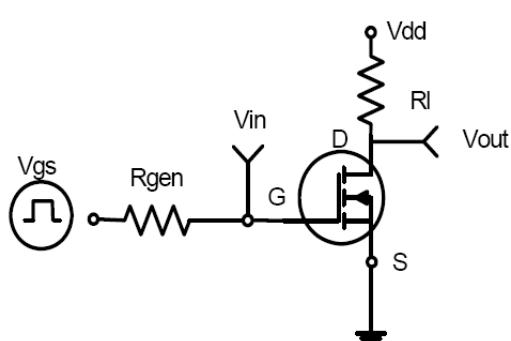
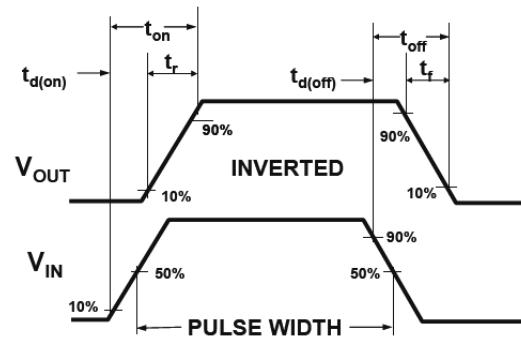
**GL Silicon N-Channel Power MOSFET**
**Source-Drain Diode Characteristics**

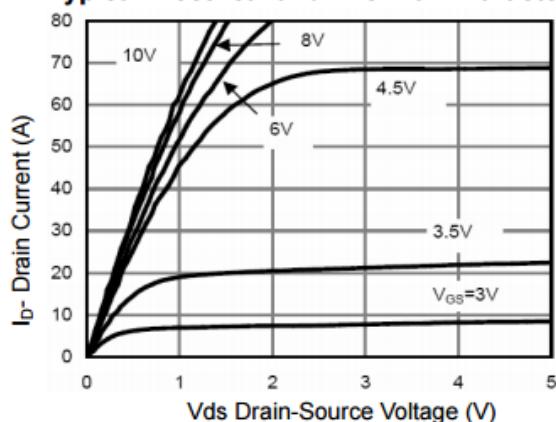
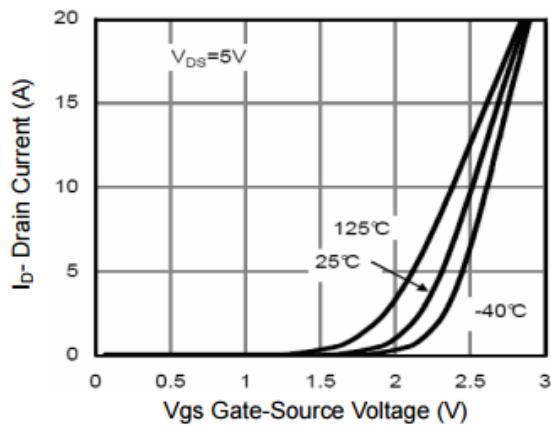
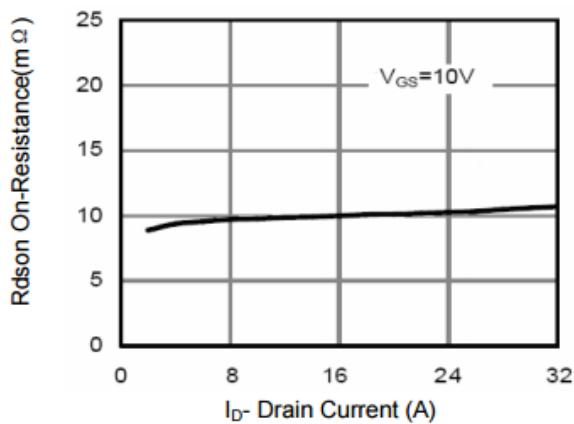
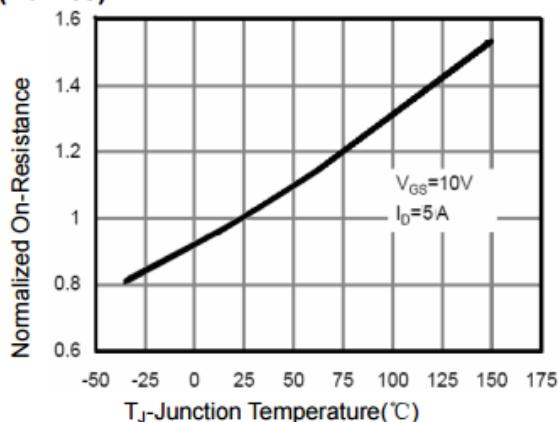
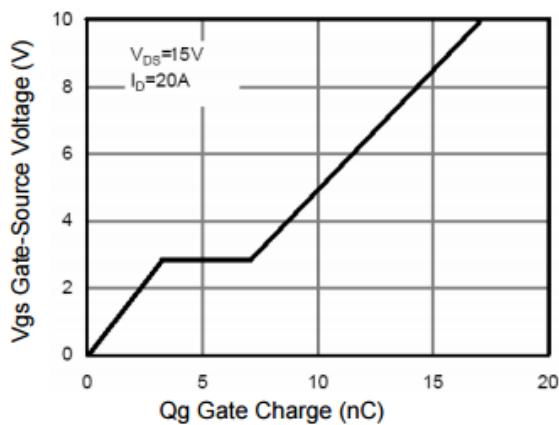
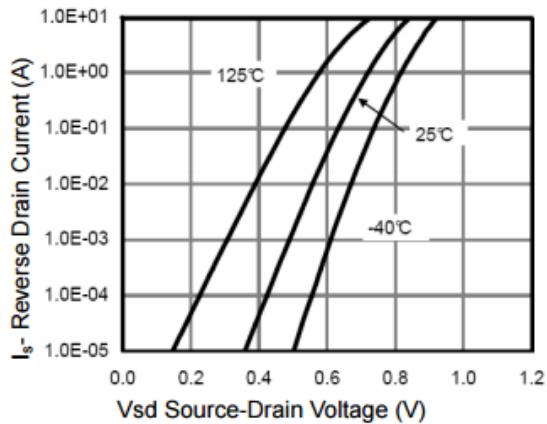
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$I_S$	Continuous Source Current (Body Diode)		--	--	8	A
$I_{SM}$	Maximum Pulsed Current (Body Diode)		--	--	32	A
$V_{SD}$	Diode Forward Voltage	$I_S=8A, V_{GS}=0V$	--	--	1.5	V
$t_{rr}$	Reverse Recovery Time	$I_S=8A, T_j=25^\circ C$	--	60	--	ns
$Q_{rr}$	Reverse Recovery Charge	$dI_F/dt=100A/\mu s, V_{GS}=0V$	--	150	--	nC

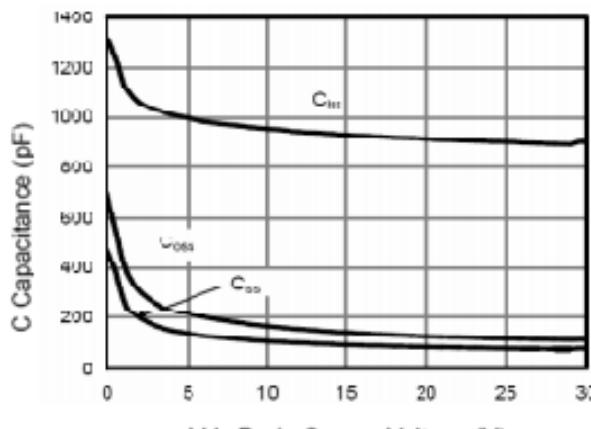
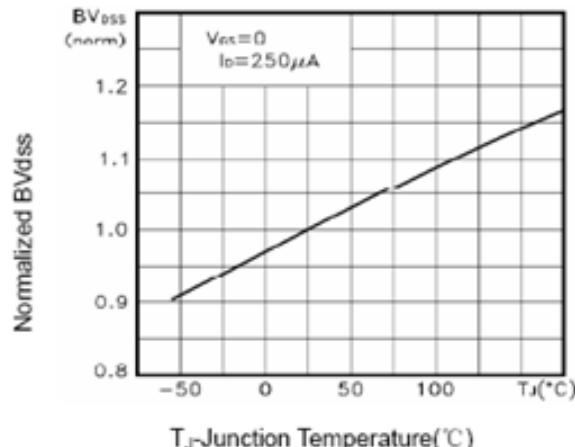
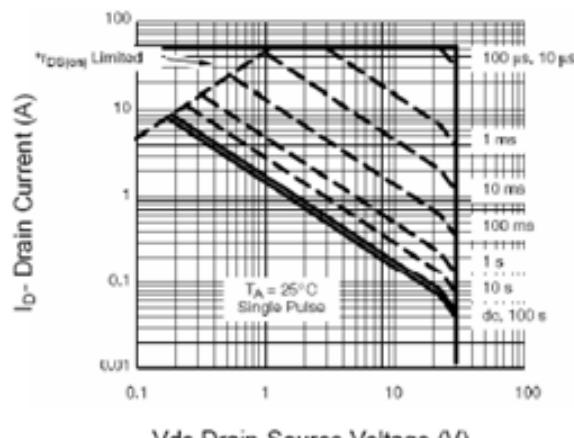
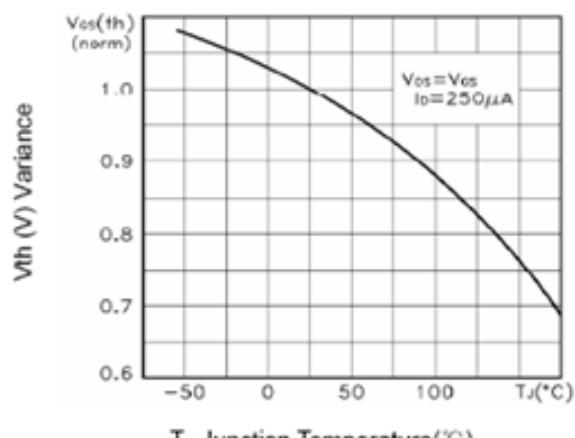
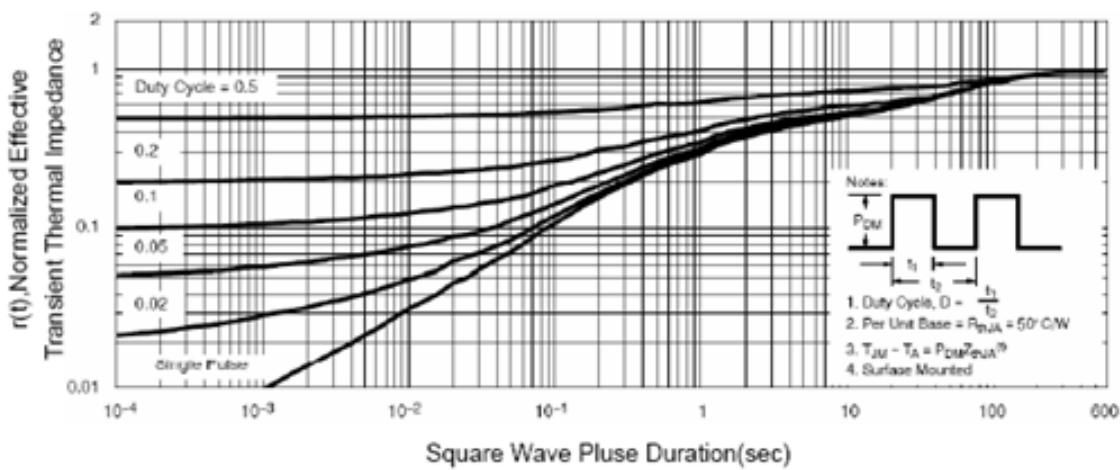
 Pulse width  $t_p \leq 380\mu s, \delta \leq 2\%$ 

Symbol	Parameter	Typ.	Units
$R_{\theta JA}$	Junction-to-Ambient	50	°C/W

<sup>a1</sup>: Repetitive rating; pulse width limited by maximum junction temperature

<sup>a2</sup>:  $T_j=25^\circ C, V_{DD}=15V, V_G=10V, L=0.1mH$ 
<sup>a3</sup>:  $I_{SD}=8A, dI/dt \leq 100A/\mu s, V_{DD} \leq BV_{DS}, \text{Start } T_j=25^\circ C$ 
**Typical Electrical and Thermal Characteristics**

**Figure 1:Switching Test Circuit**

**Figure 2:Switching Waveforms**

**GL Silicon N-Channel Power MOSFET**
**Typical Electrical and Thermal Characteristics (Curves)**

**Figure 1 Output Characteristics**

**Figure 2 Transfer Characteristics**

**Figure 3 Rdson- Drain Current**

**Figure 4 Rdson-Junction Temperature**

**Figure 5 Gate Charge**

**Figure 6 Source- Drift Diode Forward**

**GL Silicon N-Channel Power MOSFET**

**Figure 7 Capacitance vs Vds**

**Figure 9  $BV_{dss}$  vs Junction Temperature**

**Figure 8 Safe Operation Area**

**Figure 10  $V_{GS(th)}$  vs Junction Temperature**

**Figure 11 Normalized Maximum Transient Thermal Impedance**

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